



FCC RF Test Report

Product Name: LTE 2D USB Rotator

Model Number: E397Bu-501

**Report No: SYBH(Z-RF)006112011-2003
FCC ID:QISE397BU-501**

Reliability Laboratory of Huawei Technologies Co., Ltd.

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Notice

1. The laboratory has obtained the accreditation of China National Accreditation Service for Conformity Assessment (CNAS), and accreditation number: L0310.
2. The laboratory has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements. The site recognition number is 97456.
3. The laboratory has been listed by industry Canada to perform electromagnetic emission measurement. The site recognition number is 6369A-2.
4. The test report is invalid if not marked with "exclusive stamp for the test report".
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Applicant: Huawei Technologies Co., Ltd.
Address: Huawei Base, Bantian, Longgang District, Shenzhen
 518129, P.R. China
Date of Receipt Test Item: Nov.07, 2011
Start Date of Test: Nov.07, 2011
End Date of Test: Nov.24, 2011

Test Result: Pass

Approved By Nov.26, 2011 Dai Linjun *Dai Linjun*
 Date Name Signature

Reviewed By Nov.26, 2011 Cousy Xu *Cousy XU*
 Date Name Signature

Operator Nov.26, 2011 Huang Qiuliang *Huang Qiuliang*
 Date Name Signature



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1 General Information

1.1 Applied Standard

Applied Rules: 47 CFR FCC Part 2: 2010, Subpart J
47 CFR FCC Part 24: 2010, Subpart E

1.2 Test Location

Test Location 1: Reliability Laboratory of Huawei Technologies Co., Ltd.
Address: Huawei Base, Bantian, Longgang District, Shenzhen 518129, P.R.
China

1.3 Test Environment Condition

Ambient Temperature: 20 – 25 °C
Ambient Relative Humidity: 45 – 55 %
Atmospheric Pressure: 101 kPa

2 Test Summary

PCS Band			
Test Case	FCC Part No.	Requirements	Result
Transmitter Output Power	2.1046 & 24.232	Peak EIRP not exceed 2 W	Pass
Modulation Characteristics	2.1047	Digital modulation	Pass
Occupied Bandwidth	2.1049	(Not specified)	Pass
Band Edges Compliance	2.1051 & 24.238	Below -13 dBm/1%*EBW, in 1 MHz range	Pass
Spurious Emission at Antenna Terminals	2.1051 & 24.238	Below -13 dBm/1 kHz, 9 kHz to 150 kHz Below -13 dBm/10 kHz, 150 kHz to 30 MHz Below -13 dBm/1 MHz, 30 MHz to 10 th harmonics	Pass
Field Strength of Spurious Radiation	2.1053 & 24.238	Below -13 dBm/1 MHz	Pass
Frequency Stability	2.1055 & 24.235	Stay within the authorized frequency block	Pass



3 Product Description

3.1 Production Information

3.1.1 General Description

E397Bu-501 LTE/DC-HSPA+/HSPA+/WCDMA/EDGE/GPRS/GSM dual mode 9 bands 2D USB Rotator is subscriber equipment in the LTE/UMTS/GSM system. E397Bu-501 implement such functions as RF signal receiving/transmitting, LTE/DC-HSPA+/HSPA+/WCDMA and EDGE/GPRS/GSM protocol processing, data service etc. Externally it provides USB interface (to connect to the notebook etc.), USIM card interface and Micro SD card interface.

3.1.2 Board

LTE 2D USB Rotator		
E397Bu-501		
Board and Module		
Equipment Designation / Description	Serial Number	Hardware Version
MAINBOARD	E3R01A11A1800260	CD2E397UM

3.2 Test Description

3.2.1 Supported Frequency Range

Characteristics	Description
Downlink	1930 to 1990 MHz
Uplink	1850 to 1910MHz

3.2.2 Transmitter / Receiver Characteristics

Characteristics	Description
System Type	GSM UMTS
TX Output Power (per Antenna Port)	GSM system: 30dBm UMTS system: 24dBm
Channel Spacing(s) / Bandwidth(s)	GSM system: 200 kHz UMTS system: 5 MHz
Designation of Emissions	GSM system: 246KGXW (GMSK modulation), 246KG7W (8PSK modulation)) UMTS system: 4M15F9W

3.2.3 Antenna Gain

Antenna Gain(dBi):	3.45
Antenna Gain(dBd):	1.3

3.2.4 Power Supply

	Description
Power Supply Type	Directly Connected to DC /AC Power Supply
Input to Adapter (DC power)	DC Voltage Nominal: $\overline{\equiv}$ +5V DC Voltage Range: $\overline{\equiv}$ +4.75 V to +5.25V

4 General Test Conditions / Configurations

4.1 RF Channels under Test

Test Mode	TX / RX	RF Channel		
		Bottom (B)	Middle (M)	Top (T)
TM1/TM2	TX	Channel 512	Channel 661	Channel 810
		1850.2MHz	1880.0MHz	1909.8MHz
	RX	Channel 512	Channel 661	Channel 810
		1930.2 MHz	1960.0 MHz	1989.8 MHz
TM3/TM4/TM5	TX	Channel 9262	Channel9400	Channel9538
		1852.4MHz	1880.0MHz	1907.6MHz
	RX	Channel 9662	Channel 9800	Channel 9938
		1932.4 MHz	1960.0 MHz	1987.6 MHz

4.2 Test Modes

Test Mode	Test Modes Description
TM1	GSM/GPRS, GMSK modulation
TM2	EDGE, 8PSK modulation
TM3	WCDMA QPSK modulation
TM4	HSDPA 16QAM modulation
TM5	HSUPA 16QAM modulation

4.3 Test Environments

Environment Parameter	Selected Values During Tests	
Relative Humidity	Ambient	
Temperature	TN	Ambient
Voltage	VL	4.75V
	VN	5.0V
	VH	5.25V

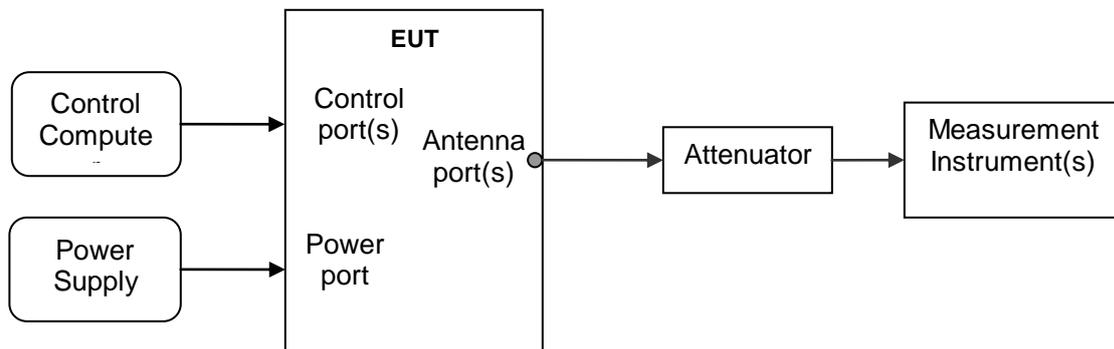
NOTE: VL= lower extreme test voltages
VN= nominal voltage
VH= upper extreme test voltage
TN= nominal temperature

4.4 Test Setups

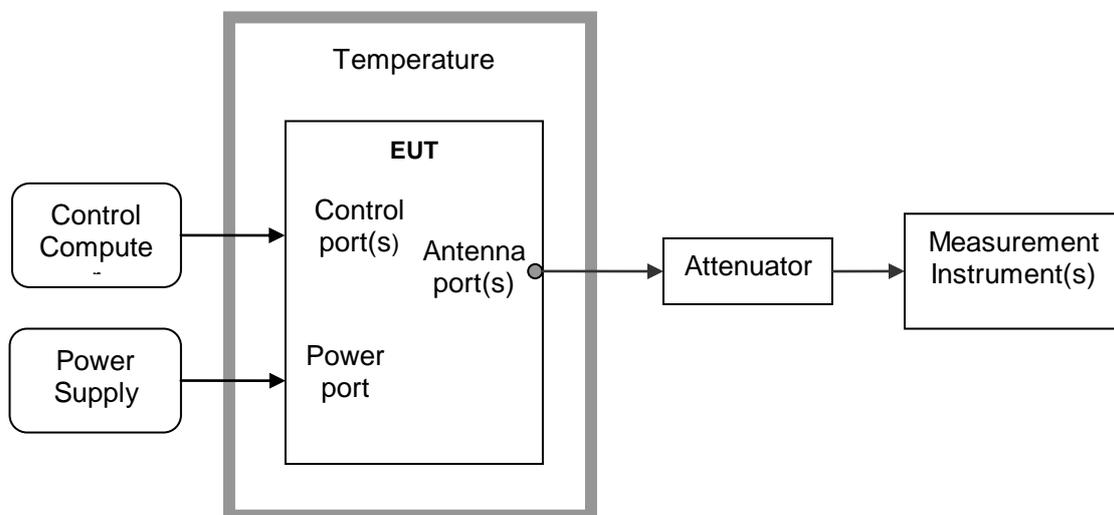
4.4.1 General Test Setup Configurations

Configuration	Description
Test Antenna Ports	Until otherwise declared, all TX tests are ONLY performed at the main Transmitter antenna port (e.g. TRXA, TXA and so on) of the EUT, and all RX tests are ONLY performed at the main Receiver antenna port (e.g. TRXA, RXA and so on) of the EUT.
Multiple RF Sources	Other than the tested RF source of the EUT, other RF source(s) are disabled or shutdown during measurements.

4.4.2 Test Setup 1



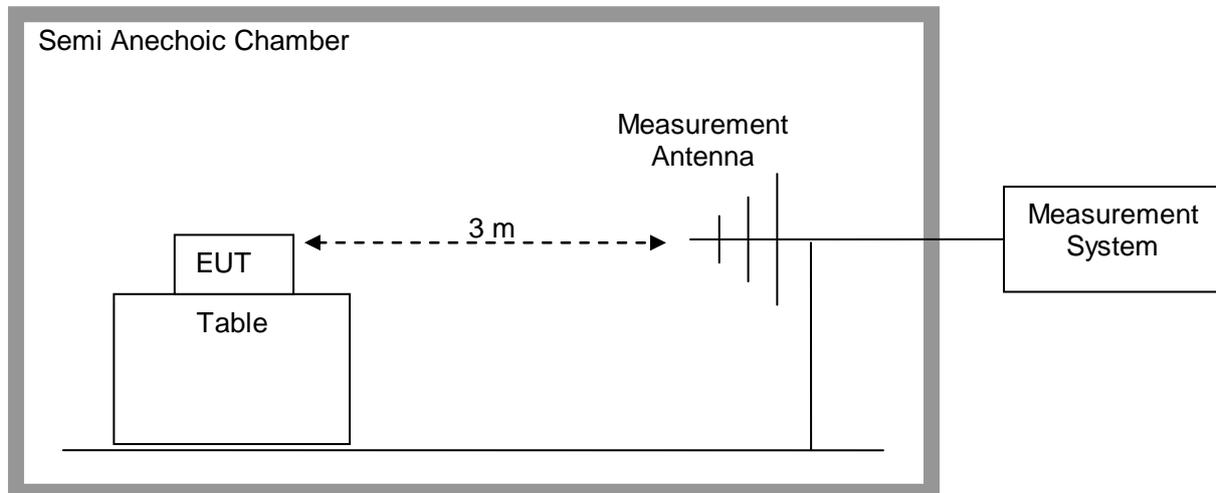
4.4.3 Test Setup 2



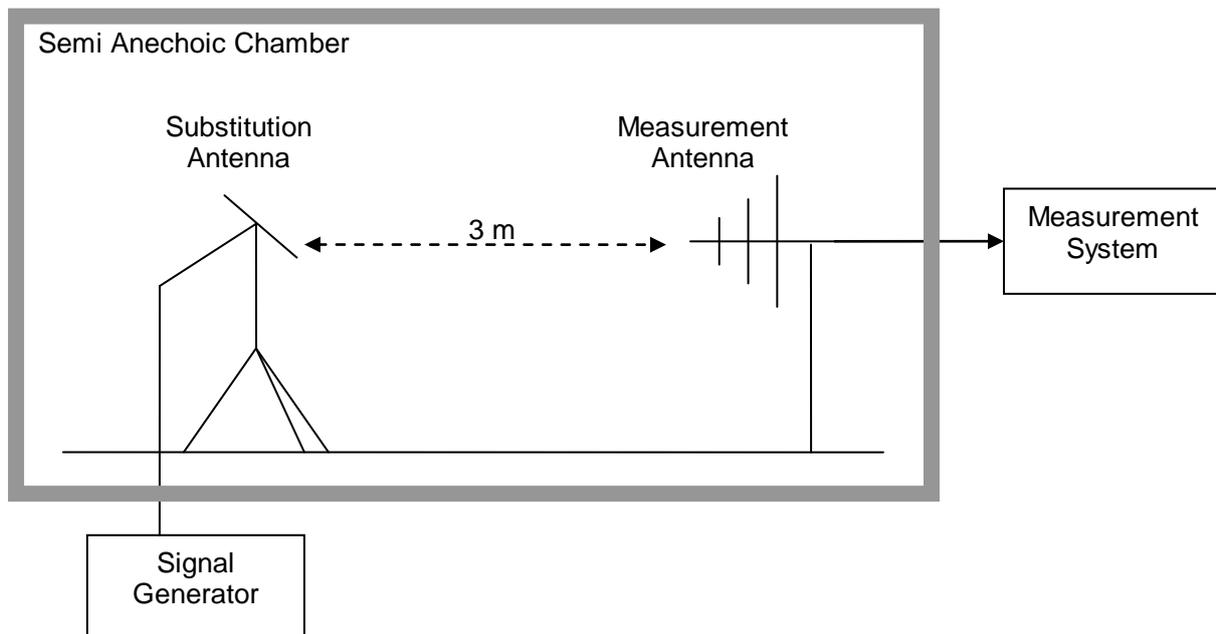
4.4.4 Test Setup 3

NOTE: Effective Isotropic radiated power (EIRP) refers to the radiation power output of the EUT, assuming all emissions are radiated from half-wave dipole antennas.

Step 1: Pre-test



Step 2: Substitution method to verify the maximum EIRP



4.5 Test Conditions

Test Case	Test Conditions	
Transmitter Output Power	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1/ Setup 3
	Detector	RMS
	RF Channels (TX)	B, M, T
	Test Mode	TM1/TM2/TM3/TM4/TM5
Modulation Characteristics	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	RF Channels (TX)	M
	Test Mode	TM1/TM2/TM3
Occupied Bandwidth	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	Detector	PK
	RF Channels (TX)	B, M, T
	Test Mode	TM1/TM2/TM3
Band Edges Compliance	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	Detector	RMS
	RF Channels (TX)	B, T
	Test Mode	TM1/TM2/TM3
Spurious Emission at Antenna Terminals	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	Detector	PK
	RF Channels (TX)	B, M, T
	Test Mode	TM1/TM2/TM3
Field Strength of Spurious Radiation	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 3
	Detector	PK
	RF Channels (TX)	M
	Test Mode	TM1/TM2/TM3/TM4/TM5
Frequency Stability	Test Configuration	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage; (2) 85%, 100% and 115% of Rated Voltage at Ambient Temperature.
	Test Setup	Test Setup 2
	RF Channels (TX)	M



Test Case	Test Conditions	
	Test Mode	TM1/TM2/TM3



5 Main Test Instruments

Equipment Description	Manufacturer	Model	Serial Number	Calibrated until
Power supply	KEITHLEY	2303	1288003	Sep.27,2012
Universal Radio Communication Tester	R&S	CMU200	105822	Oct.24.2012
Wireless Communication Test set	Agilent	N4010A	MY49081592	Dec.14.2011
Universal Radio Communication Tester	Agilent	E5515C	MY50260239	Aug.31,2012
Spectrum Analyzer	Agilent	E4440A	MY49420179	Apr.20,2012
Signal Analyzer	R&S	FSQ31	200021	Sep.27,2012
Temperature Chamber	WEISS	WKL64	24600294	Jan.03,2012
Signal generator	Agilent	E8257D	MY49281095	Jul.9.2012
Vector Signal Generator	R&S	SMU200A	104162	Sep.07,2012
Test receiver	R&S	ESU26	100150	May.24.2012
Tunable Dipole	Schwarzbeck	D69250-UHAP/D69250-VHAP	919/1009	Dec.13.2011
Tunable Dipole	Schwarzbeck	D69250-UHAP/D69250-VHAP	979/917	Dec.13.2011
Horn Antenna	R & S	HF906	100683	May.16, 2012
Horn Antenna	R & S	HF906	100684	May.16, 2012
Broadband Antenna	Schwarzbeck	VULB 9163	9163-357	Sep.15, 2012
Broadband Antenna	Schwarzbeck	VULB 9163	9163-356	Sep.15, 2012



6 Test Results

No.	Test Item	Test Result
1	Transmitter Output Power	Appendix A
2	Modulation Characteristics	Appendix B
3	Occupied Bandwidth	Appendix C
4	Band Edges Compliance	Appendix D
5	Spurious Emission at Antenna Terminals	Appendix E
6	Field Strength of Spurious Radiation	Appendix F
7	Frequency Stability	Appendix G

7 Measurement Uncertainty

For a 95% confidence level ($k=2$), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item		Extended Uncertainty
Transmitter Output Power	Power (dBm)	U =0.39 dB
Occupied Bandwidth	Magnitude (%)	U=0.2%
Band Edge Compliance	Disturbance Power (dBm)	U=2.0 dB
Conducted Spurious Emissions	Disturbance Power (dBm)	U=2.0 dB
Field Strength of Spurious Radiation	ERP (dBm)	U=4.6 dB (30 MHz – 1GHz) U=3.0 dB (above 1 GHz)
Frequency Stability	Frequency Accuracy (ppm)	U=0.21 ppm